


<b>Search Notes</b> 	<b>Application/Control No.</b> 10575561	<b>Applicant(s)/Patent Under Reexamination</b> WHITE, MICHAEL DAVID EDWARDS
	<b>Examiner</b> BENJAMIN P LEE	<b>Art Unit</b> 3641

SEARCHED			
Class	Subclass	Date	Examiner
102	317	11/16/2008	LEE
102	311	11/16/2008	LEE
102	202.12	11/16/2008	LEE
102	275.4	11/16/2008	LEE
102	275.11	11/16/2008	LEE
102	275.12	11/16/2008	LEE
102	320	11/16/2008	LEE

SEARCH NOTES		
Search Notes	Date	Examiner
Text search	11/16/2008	LEE

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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